Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10565468	LIU ET AL.
Examiner	Art Unit
Brian Nouven	2416

	Examiner Brian Nguyen	Art Unit 2416

SEARCHED			
Class	Subclass	Date	Examiner
370	468,230,465,252,395.4,349,350	11/20/08	MC
709	224	11/20/08	MC
725	95,116	11/20/08	MC

SEARCH NOTES		
Search Notes	Date	Examiner
East (All DBs)	11/20/08	MC
east	6/4/09	bn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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